RENESAS

HIP4082

80V, 1.25A Peak Current H-Bridge FET Driver

DATASHEET

FN3676 Rev 5.00 September 30, 2015

The HIP4082 is a medium frequency, medium voltage H-Bridge N-Channel MOSFET driver IC, available in 16 lead plastic SOIC (N) and DIP packages.

Specifically targeted for PWM motor control and UPS applications, bridge based designs are made simple and flexible with the HIP4082 H-bridge driver. With operation up to 80V, the device is best suited to applications of moderate power levels.

Similar to the HIP4081, it has a flexible input protocol for driving every possible switch combination except those which would cause a shoot-through condition. The HIP4082's reduced drive current allows smaller packaging and it has a much wider range of programmable dead times (0.1 to 4.5μ s) making it ideal for switching frequencies up to 200kHz. The HIP4082 does not contain an internal charge pump, but does incorporate non-latching level-shift translation control of the upper drive circuits.

This set of features and specifications is optimized for applications where size and cost are important. For applications needing higher drive capability the HIP4080A and HIP4081A are recommended.

Features

- Independently Drives 4 N-Channel FET in Half Bridge or Full Bridge Configurations
- Bootstrap Supply Max Voltage to 95VDC
- Drives 1000pF Load in Free Air at 50°C with Rise and Fall Times of Typically 15ns
- User-Programmable Dead Time (0.1 to 4.5µs)
- DIS (Disable) Overrides Input Control and Refreshes Bootstrap Capacitor when Pulled Low
- Input Logic Thresholds Compatible with 5V to 15V Logic Levels
- Shoot-Through Protection
- Undervoltage Protection
- Pb-Free Plus Anneal Available (RoHS Compliant)

Applications

- UPS Systems
- DC Motor Controls
- · Full Bridge Power Supplies
- · Switching Power Amplifiers
- · Noise Cancellation Systems
- · Battery Powered Vehicles
- Peripherals
- Medium/Large Voice Coil Motors
- · Related Literature
 - TB363, Guidelines for Handling and Processing Moisture Sensitive Surface Mount Devices (SMDs)



Ordering Information

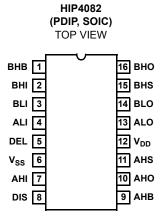
PART NUMBER	PART MARKING	TEMP. RANGE (°C)	PACKAGE	PKG. DWG. #
HIP4082IB*	HIP4082IB	-55 to +125	16 Ld SOIC (N)	M16.15
HIP4082IBZ* (Note)	4082IBZ	-55 to +125	16 Ld SOIC (N) (Pb-free)	M16.15
HIP4082IP (No longer avail- able, recommended replace- ment: HIP4082IPZ)	HIP4082IP	-55 to +125	16 Ld PDIP	E16.3
HIP4082IPZ (Note)	HIP4082IPZ	-55 to +125	16 Ld PDIP** (Pb-free)	E16.3

*Add "T" suffix for tape and reel.

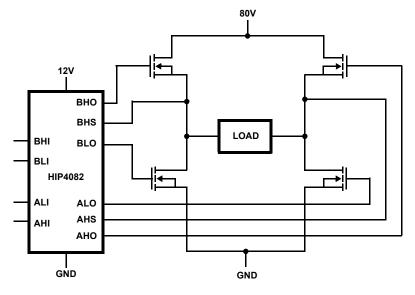
NOTE: Intersil Pb-free plus anneal products employ special Pb-free material sets; molding compounds/die attach materials and 100% matte tin plate termination finish, which are RoHS compliant and compatible with both SnPb and Pb-free soldering operations. Intersil Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020.

**Pb-free PDIPs can be used for through hole wave solder processing only. They are not intended for use in Reflow solder processing applications.

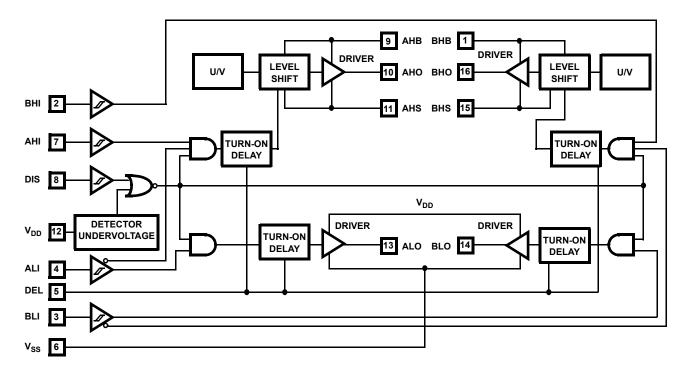
Pinout



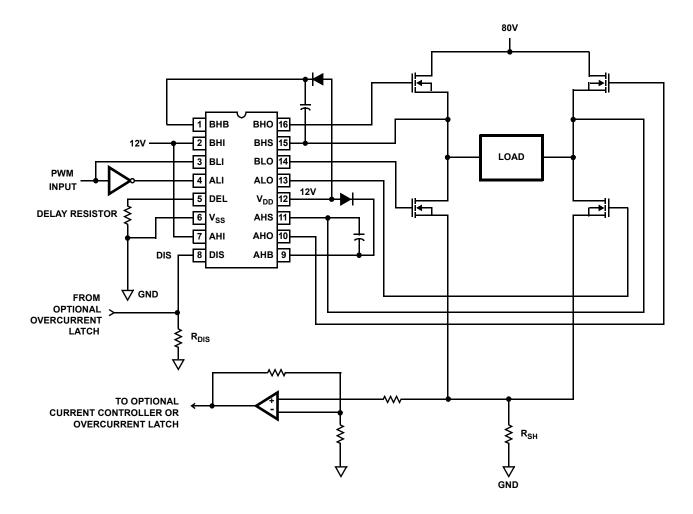
Application Block Diagram



Functional Block Diagram







Absolute Maximum Ratings

$C_{\rm upphy}$ /oltage // 0.2 / to 16 //
Supply Voltage, V _{DD} 0.3V to 16V
Logic I/O Voltages0.3V to V _{DD} +0.3V
Voltage on AHS, BHS6V (Transient) to 80V (25°C to 150°C)
Voltage on AHS, BHS6V (Transient) to 70V (-55°C to150°C)
Voltage on AHB, BHB V _{AHS, BHS} -0.3V to V _{AHS, BHS} +V _{DD}
Voltage on ALO, BLO V _{SS} -0.3V to V _{DD} +0.3V
Voltage on AHO, BHO V _{AHS, BHS} -0.3V to V _{AHB, BHB} +0.3V Input
Current, DEL
Phase Slew Rate 20V/ns
NOTE: All voltages are relative V _{SS} unless otherwise specified.

Operating Conditions

Supply Voltage, V _{DD} +8.5V to +15	V
Voltage on V _{SS}	V
Voltage on AHB, BHBV _{AHS, BHS} +7.5V to V _{AHS, BHS} +V _D	
Input Current, DEL4mA to -100µ	А

Thermal Information

Thermal Resistance	θ _{JA} (°C/W)
SOIC Package	115
DIP Package	90
Maximum Power Dissipation.	
Storage Temperature Range65°	°C to +150°C
Operating Max. Junction Temperature	+150°C
Lead Temperature (Soldering 10s)	+300°C
(For SOIC - Lead Tips Only))	

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

Electrical Specifications $V_{DD} = V_{AHB} = V_{BHB} = 12V$, $V_{SS} = V_{AHS} = V_{BHS} = 0V$, $R_{DEL} = 100K$

			T _J = +25°C			T _J = -55°C TO +150°C		
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	MIN	MAX	UNITS
SUPPLY CURRENTS & UNDER VOLTA	GE PROTECTION							
V _{DD} Quiescent Current	I _{DD}	All inputs = 0V, R _{DEL} = 100K	1.2	2.3	3.5	0.85	4	mA
		All inputs = 0V, R _{DEL} = 10K	2.2	4.0	5.5	1.9	6.0	mA
V _{DD} Operating Current	I _{DDO}	f = 50kHz, no load	1.5	2.6	4.0	1.1	4.2	mA
		50kHz, no load, R_{DEL} = 10k Ω	2.5	4.0	6.4	2.1	6.6	mA
AHB, BHB Off Quiescent Current	I _{AHBL} , I _{BHBL}	AHI = BHI = 0V	0.5	1.0	1.5	0.4	1.6	mA
AHB, BHB On Quiescent Current	I _{AHBH} , I _{BHBH}	AHI = BHI = V _{DD}	65	145	240	40	250	μA
AHB, BHB Operating Current	I _{AHBO} , I _{BHBO}	f = 50kHz, CL = 1000pF	.65	1.1	1.8	.45	2.0	mA
AHS, BHS Leakage Current	I _{HLK}	$V_{AHS} = V_{BHS} = 80V$ $V_{AHB} = V_{BHB} = 96$ V_{DD} = Not Connected	-	-	1.0	-	-	μΑ
V _{DD} Rising Undervoltage Threshold	V _{DDUV+}		6.8	7.6	8.25	6.5	8.5	V
V _{DD} Falling Undervoltage Threshold	V _{DDUV-}		6.5	7.1	7.8	6.25	8.1	V
Undervoltage Hysteresis	UVHYS		0.17	0.4	0.75	0.15	0.90	V
AHB, BHB Undervoltage Threshold	VHBUV	Referenced to AHS & BHS	5	6.0	7	4.5	7.5	V
INPUT PINS: ALI, BLI, AHI, BHI, & DIS								
Low Level Input Voltage	VIL	Full Operating Conditions	-	-	1.0	-	0.8	V
High Level Input Voltage	V _{IH}	Full Operating Conditions	2.5	-	-	2.7		V
Input Voltage Hysteresis			-	35	-	-	-	mV
Low Level Input Current	IIL	V _{IN} = 0V, Full Operating Conditions	-145	-100	-60	-150	-50	μA
High Level Input Current	I _{IH}	V _{IN} = 5V, Full Operating Conditions	-1	-	+1	-10	+10	μA
TURN-ON DELAY PIN DEL						1	1	1
Dead Time	T _{DEAD}	R _{DEL} = 100K	2.5	4.5	8.0	2.0	8.5	μS
		R _{DEL} = 10K	0.27	0.5	0.75	0.2	0.85	μS

Electrical Specifications $V_{DD} = V_{AHB} = V_{BHB} = 12V$, $V_{SS} = V_{AHS} = 0V$, $R_{DEL} = 100K$ (Continued)

			T,	= +25 ر	°C		-55°C 150°C	
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	ТҮР	MAX	MIN	MAX	UNITS
GATE DRIVER OUTPUT PINS: ALO, BLO,	AHO, & BHO							
Low Level Output Voltage	V _{OL}	I _{OUT} = 50mA	0.65		1.1	0.5	1.2	V
High Level Output Voltage	V _{DD} -V _{OH}	I _{OUT} = -50mA	0.7		1.2	0.5	1.3	V
Peak Pullup Current	I _O +	V _{OUT} = 0V	1.1	1.4	2.5	0.85	2.75	А
Peak Pulldown Current	I _O -	V _{OUT} = 12V	1.0	1.3	2.3	0.75	2.5	А

$\label{eq:second} \textbf{Switching Specifications} \quad V_{DD} = V_{AHB} = V_{BHB} = 12 \text{V}, \ V_{SS} = V_{AHS} = V_{BHS} = 0 \text{V}, \ \text{R}_{DEL} = 100 \text{K}, \ \text{C}_{L} = 1000 \text{F}.$

			T _J = +25°C			T _J = -55°C TO +150°C			
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	MIN TYP MAX		MIN MAX		UNITS	
Lower Turn-off Propagation Delay (ALI-ALO, BLI-BLO)	T _{LPHL}		-	25	50	-	70	ns	
Upper Turn-off Propagation Delay (AHI-AHO, BHI-BHO)	T _{HPHL}		-	55	80	-	100	ns	
Lower Turn-on Propagation Delay (ALI-ALO, BLI-BLO)	T _{LPLH}		-	40	85	-	100	ns	
Upper Turn-on Propagation Delay (AHI-AHO, BHI-BHO)	T _{HPLH}		-	75	110	-	150	ns	
Rise Time	T _R		-	9	20	-	25	ns	
Fall Time	T _F		-	9	20	-	25	ns	
Minimum Input Pulse Width	T _{PWIN-ON/OFF}		50	-	-	50	-	ns	
Output Pulse Response to 50 ns Input Pulse	T _{PWOUT}			63			80	ns	
Disable Turn-off Propagation Delay (DIS - Lower Outputs)	T _{DISLOW}		-	50	80	-	90	ns	
Disable Turn-off Propagation Delay (DIS - Upper Outputs)	T _{DISHIGH}		-	75	100	-	125	ns	
Disable Turn-on Propagation Delay (DIS - ALO & BLO)	T _{DLPLH}		-	40	70	-	100	ns	
Disable Turn-on Propagation Delay (DIS- AHO & BHO)	T _{DHPLH}	R _{DEL} = 10K	-	1.2	2	-	3	μS	
Refresh Pulse Width (ALO & BLO)	T _{REF-PW}		375	580	900	350	950	ns	

TRUTH TABLE

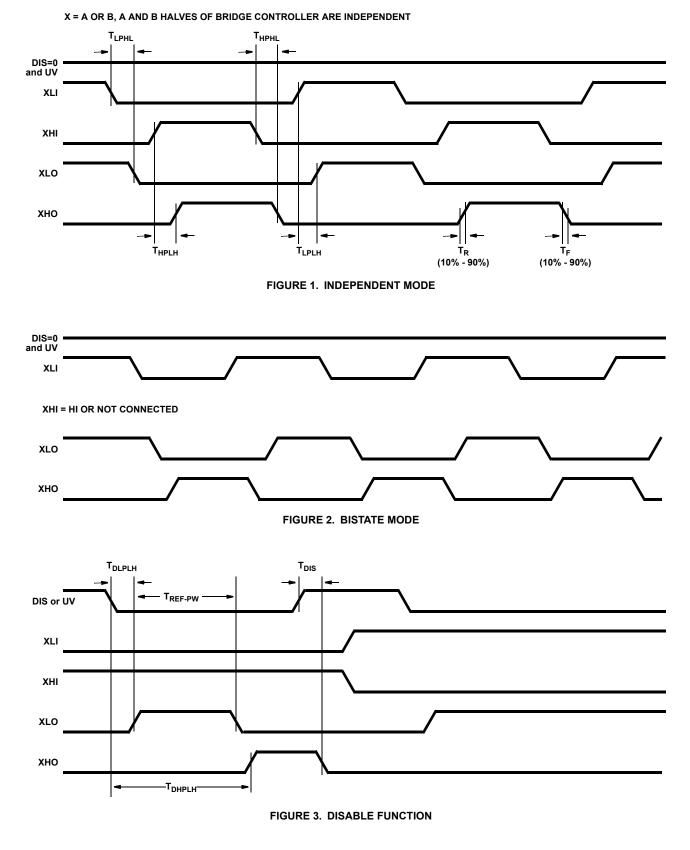
		OUTPUT				
ALI, BLI	AHI, BHI	VDDUV	VHBUV	DIS	ALO, BLO	AHO, BHO
Х	Х	х	х	1	0	0
Х	х	1	х	х	0	0
0	Х	0	1	0	0	0
1	х	0	х	0	1	0
0	1	0	0	0	0	1
0	0	0	0	0	0	0

NOTE: X signifies that input can be either a "1" or "0".

Pin Descriptions

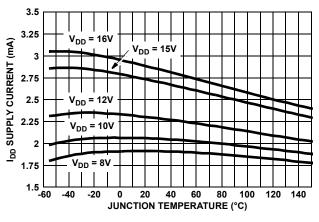
PIN NUMBER	SYMBOL	DESCRIPTION
1	BHB	B High-side Bootstrap supply. External bootstrap diode and capacitor are required. Connect cathode of bootstrap diode and positive side of bootstrap capacitor to this pin.
2	BHI	B High-side Input. Logic level input that controls BHO driver (Pin 16). BLI (Pin 3) high level input overrides BHI high level input to prevent half-bridge shoot-through, see Truth Table. DIS (Pin 8) high level input overrides BHI high level input. The pin can be driven by signal levels of 0V to 15V (no greater than V _{DD}).
3	BLI	B Low-side Input. Logic level input that controls BLO driver (Pin 14). If BHI (Pin 2) is driven high or not connected externally then BLI controls both BLO and BHO drivers, with dead time set by delay currents at DEL (Pin 5). DIS (Pin 8) high level input overrides BLI high level input. The pin can be driven by signal levels of 0V to 15V (no greater than V _{DD}).
4	ALI	A Low-side Input. Logic level input that controls ALO driver (Pin 13). If AHI (Pin 7) is driven high or not connected externally then ALI controls both ALO and AHO drivers, with dead time set by delay currents at DEL (Pin 5). DIS (Pin 8) high level input overrides ALI high level input. The pin can be driven by signal levels of 0V to 15V (no greater than V _{DD}).
5	DEL	Turn-on DELay. Connect resistor from this pin to V_{SS} to set timing current that defines the dead time between drivers. All drivers turn-off with no adjustable delay, so the DEL resistor guarantees no shoot-through by delaying the turn-on of all drivers. The voltage across the DEL resistor is approximately Vdd -2V.
6	V _{SS}	Chip negative supply, generally will be ground.
7	AHI	A High-side Input. Logic level input that controls AHO driver (Pin 10). ALI (Pin 4) high level input overrides AHI high level input to prevent half-bridge shoot-through, see Truth Table. DIS (Pin 8) high level input overrides AHI high level input. The pin can be driven by signal levels of 0V to 15V (no greater than V _{DD}).
8	DIS	DISable input. Logic level input that when taken high sets all four outputs low. DIS high overrides all other inputs. When DIS is taken low the outputs are controlled by the other inputs. The pin can be driven by signal levels of 0V to 15V (no greater than V_{DD}).
9	AHB	A High-side Bootstrap supply. External bootstrap diode and capacitor are required. Connect cathode of bootstrap diode and positive side of bootstrap capacitor to this pin.
10	AHO	A High-side Output. Connect to gate of A High-side power MOSFET.
11	AHS	A High-side Source connection. Connect to source of A High-side power MOSFET. Connect negative side of bootstrap capacitor to this pin.
12	V _{DD}	Positive supply to control logic and lower gate drivers. De-couple this pin to V _{SS} (Pin 6).
13	ALO	A Low-side Output. Connect to gate of A Low-side power MOSFET.
14	BLO	B Low-side Output. Connect to gate of B Low-side power MOSFET.
15	BHS	B High-side Source connection. Connect to source of B High-side power MOSFET. Connect negative side of bootstrap capacitor to this pin.
16	BHO	B High-side Output. Connect to gate of B High-side power MOSFET.

Timing Diagrams

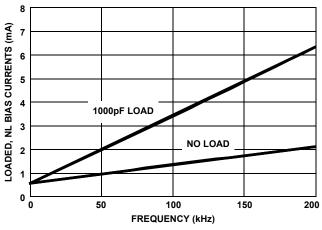


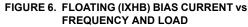


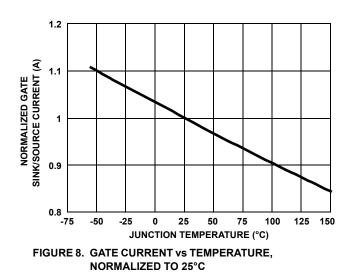
Performance Curves











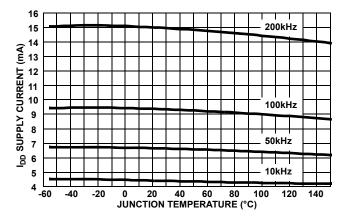


FIGURE 5. V_{DD} SUPPLY CURRENT vs TEMPERATURE AND SWITCHING FREQUENCY (1000pF LOAD)

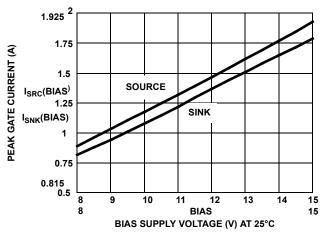
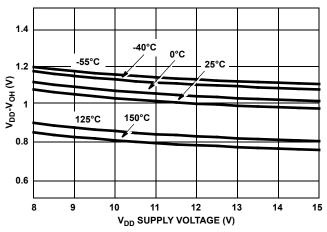


FIGURE 7. GATE SOURCE/SINK PEAK CURRENT vs BIAS SUPPLY VOLTAGE AT 25°C





Performance Curves (Continued)

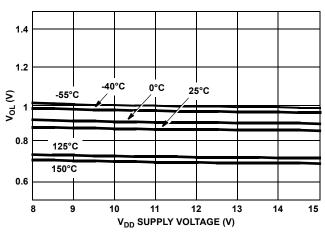


FIGURE 10. V_{OL} vs BIAS VOLTAGE AND TEMPERATURE

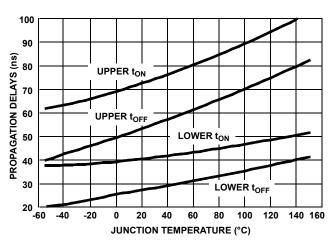
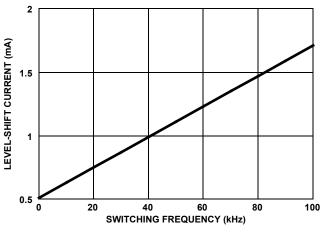
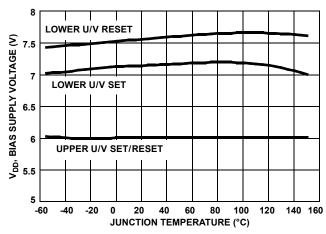


FIGURE 12. UPPER LOWER TURN-ON/TURN-OFF PROPAGATION DELAY vs TEMPERATURE









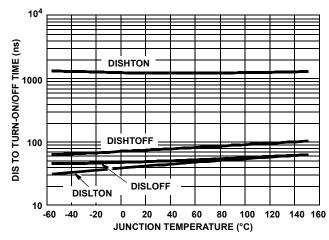
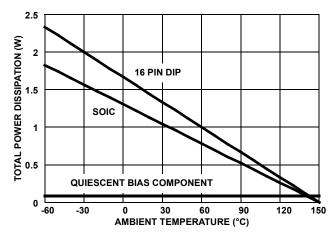
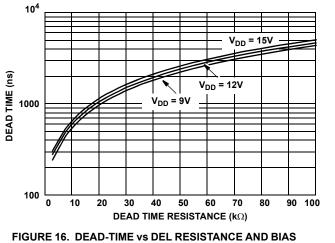


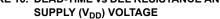
FIGURE 13. UPPER/LOWER DIS(ABLE) TO TURN-ON/OFF vs TEMPERATURE (°C)





Performance Curves (Continued)





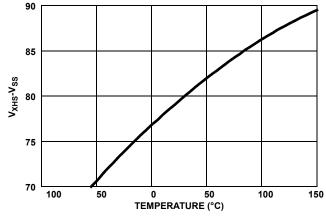


FIGURE 17. MAXIMUM OPERATING PEAK AHS/BHS VOLTAGE vs TEMPERATURE

Revision History

The revision history provided is for informational purposes only and is believed to be accurate, but not warranted. Please go to the web to make sure that you have the latest revision.

DATE	REVISION	CHANGE
September 30, 2015	FN3676.5	Updated the Ordering Information Table on page 2. Added Revision History and About Intersil sections.

About Intersil

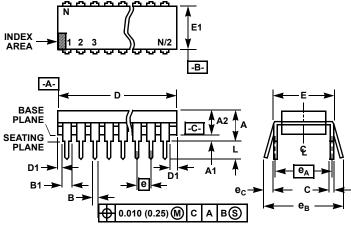
Intersil Corporation is a leading provider of innovative power management and precision analog solutions. The company's products address some of the largest markets within the industrial and infrastructure, mobile computing and high-end consumer markets.

For the most updated datasheet, application notes, related documentation and related parts, please see the respective product information page found at <u>www.intersil.com</u>.

You may report errors or suggestions for improving this datasheet by visiting <u>www.intersil.com/ask</u>.

Reliability reports are also available from our website at www.intersil.com/support.

Dual-In-Line Plastic Packages (PDIP)



NOTES:

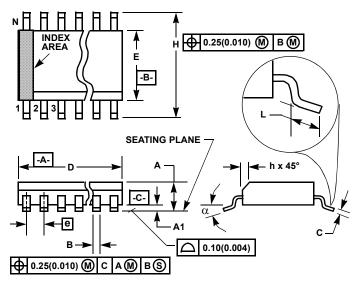
- 1. Controlling Dimensions: INCH. In case of conflict between English and Metric dimensions, the inch dimensions control.
- 2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
- 3. Symbols are defined in the "MO Series Symbol List" in Section 2.2 of Publication No. 95.
- 4. Dimensions A, A1 and L are measured with the package seated in JE-DEC seating plane gauge GS-3.
- 5. D, D1, and E1 dimensions do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.010 inch (0.25mm).
- E and e_A are measured with the leads constrained to be perpendicular to datum -C-.
- 7. e_B and e_C are measured at the lead tips with the leads unconstrained. e_C must be zero or greater.
- B1 maximum dimensions do not include dambar protrusions. Dambar protrusions shall not exceed 0.010 inch (0.25mm).
- 9. N is the maximum number of terminal positions.
- 10. Corner leads (1, N, N/2 and N/2 + 1) for E8.3, E16.3, E18.3, E28.3, E42.6 will have a B1 dimension of 0.030 0.045 inch (0.76 1.14mm).

E16.3 (JEDEC MS-001-BB ISSUE D) 16 LEAD DUAL-IN-LINE PLASTIC PACKAGE

	INC	HES	MILLIM	IETERS	
SYMBOL	MIN	MAX	MIN	MAX	NOTES
А	-	0.210	-	5.33	4
A1	0.015	-	0.39	-	4
A2	0.115	0.195	2.93	4.95	-
В	0.014	0.022	0.356	0.558	-
B1	0.045	0.070	1.15	1.77	8, 10
С	0.008	0.014	0.204	0.355	-
D	0.735	0.775	18.66	19.68	5
D1	0.005	-	0.13	-	5
Е	0.300	0.325	7.62	8.25	6
E1	0.240	0.280	6.10	7.11	5
е	0.100	BSC	2.54	BSC	-
e _A	0.300	BSC	7.62 BSC		6
e _B	-	0.430	-	10.92	7
L	0.115	0.150	2.93	3.81	4
Ν	1	6	16		9
				B	ev. 0 12/93

Rev. 0 12/93

Small Outline Plastic Packages (SOIC)



NOTES:

- 1. Symbols are defined in the "MO Series Symbol List" in Section 2.2 of Publication Number 95.
- 2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
- Dimension "D" does not include mold flash, protrusions or gate burrs. Mold flash, protrusion and gate burrs shall not exceed 0.15mm (0.006 inch) per side.
- 4. Dimension "E" does not include interlead flash or protrusions. Interlead flash and protrusions shall not exceed 0.25mm (0.010 inch) per side.
- 5. The chamfer on the body is optional. If it is not present, a visual index feature must be located within the crosshatched area.
- 6. "L" is the length of terminal for soldering to a substrate.
- 7. "N" is the number of terminal positions.
- 8. Terminal numbers are shown for reference only.
- 9. The lead width "B", as measured 0.36mm (0.014 inch) or greater above the seating plane, shall not exceed a maximum value of 0.61mm (0.024 inch).
- Controlling dimension: MILLIMETER. Converted inch dimensions are not necessarily exact.

M16.15 (JEDEC MS-012-AC ISSUE C)
16 LEAD NARROW BODY SMALL OUTLINE PLASTIC PACKAGE

	INCHES		MILLIMETERS		
SYMBOL	MIN	MAX	MIN	MAX	NOTES
А	0.0532	0.0688	1.35	1.75	-
A1	0.0040	0.0098	0.10	0.25	-
В	0.013	0.020	0.33	0.51	9
С	0.0075	0.0098	0.19	0.25	-
D	0.3859	0.3937	9.80	10.00	3
E	0.1497	0.1574	3.80	4.00	4
е	0.050 BSC		1.27 BSC		-
Н	0.2284	0.2440	5.80	6.20	-
h	0.0099	0.0196	0.25	0.50	5
L	0.016	0.050	0.40	1.27	6
Ν	16		16		7
α	0°	8°	0°	8°	-

Rev. 1 6/05

© Copyright Intersil Americas LLC 2003-2015. All Rights Reserved. All trademarks and registered trademarks are the property of their respective owners.

For additional products, see www.intersil.com/en/products.html

Intersil products are manufactured, assembled and tested utilizing ISO9001 quality systems as noted in the quality certifications found at www.intersil.com/en/support/qualandreliability.html

Intersil products are sold by description only. Intersil may modify the circuit design and/or specifications of products at any time without notice, provided that such modification does not, in Intersil's sole judgment, affect the form, fit or function of the product. Accordingly, the reader is cautioned to verify that datasheets are current before placing orders. Information furnished by Intersil is believed to be accurate and reliable. However, no responsibility is assumed by Intersil or its subsidiaries for its use; nor for any infringements of patents or other rights of third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of Intersil or its subsidiaries.

For information regarding Intersil Corporation and its products, see www.intersil.com



Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

Intersil:

HIP4082IB HIP4082IPZ HIP4082IBT HIP4082IBZ HIP4082IBZT HIP4082IBZTR5676